PTO/SB/08A (08-00) - MODIFIED Approved for use through 10/31/2002. OMB 0651-0031 Patent and Trademark Office: U.S. DEPARTMENT OF COMMERCE leas type a plus sign (+) inside this box 14 **Application Number** 10/040,915 Substitute for form 1449A/PTO **Filing Date** 1/5/02 INFORMATION DISCLOSURE **First Named Inventor** Steven Teig STATEMENT BY APPLICANT Group Art Unit 2825 (use as many sheets as necessary) **Examiner Name** HomPs **Attorney Docket Number** SPLX.P0022 Sheet 1

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INFORMATION DISCLOSURE
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Application Number 10/040,915

Filing Date 1/5/02

First Named Inventor Steven Teig

Group Art Unit 2825

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**Application Number** 10/040.915 Substitute for form 1449A/PTO Filing Date 1/5/02 INFORMATION DISCLOSURE First Named Inventor Steven Teig STATEMENT BY APPLICANT Group Art Unit 2825 (use as many sheets as necessary) Examiner Name A:-Liu 1 Hompsons 7 Attorney Docket Number SPLX.P0022 Sheet 1 of

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**Application Number** 10/040.915 Substitute for form 1449A/PTO 9 2003 Filing Date 1/5/02 ORMATION DISCLOSURE First Named Inventor Steven Teig STATEMENT BY APPLICANT Group Art Unit 2825 (use as many sheets as necessary) **Examiner Name** 1 Hompson Sheet 2 of 7 Attorney Docket Number SPLX.P0022

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Based on PTO/SB/08 a & b (05-03) Approved for use through 05/31/2003. OMB 0651-0031 U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE type a plus sign (+) Inside this box → Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number **Application Number** 10/040,915 Substitute for form 1449A/PTO 9 2003 Filing Date 1/5/02 ORMATION DISCLOSURE First Named Inventor Steven Teig STATEMENT BY APPLICANT 2825 **Group Art Unit** (use as many sheets as necessary) Examiner Name A. Liu THOMPSON

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information unless it contains a valid OMB control number **Application Number** 10/040.915 Substitute for form 1449A/PTO g W Filing Date 1/5/02 INFORMATION DISCLOSURE First Named Inventor Steven Teig TATEMENT BY APPLICANT Group Art Unit 2825 (use as many sheets as necessary) **Examiner Name** A. Liu Nompson Sheet 7 SPLX.P0022 7 of Attorney Docket Number

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